Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/696,603	AKASHE ET AL.	
	Examiner	Art Unit	
	Anthony Weier	1761	

SEARCHED					
Class	Subclass	Date	Examiner		
426	656, 634, 574, 583	12/22/2005	AW		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	12/22/2005	AW		